

# SKM 100GB125DN



**SEMITRANS™ 2N**

## Ultra Fast IGBT Module

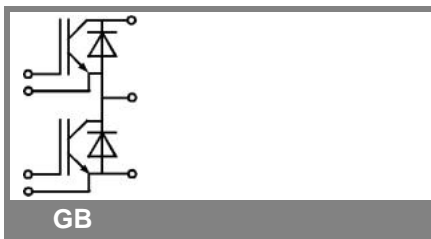
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### Features

- N channel, homogeneous Si
- Low inductance case
- Short tail current with low temperature dependence
- High short circuit capability, self limiting to  $6 \times I_{cnom}$
- Fast & soft inverse CAL diodes
- Isolated copper baseplate using DCB Direct Copper Bonding Technology
- Large clearance (10 mm) and creepage distances (20 mm)

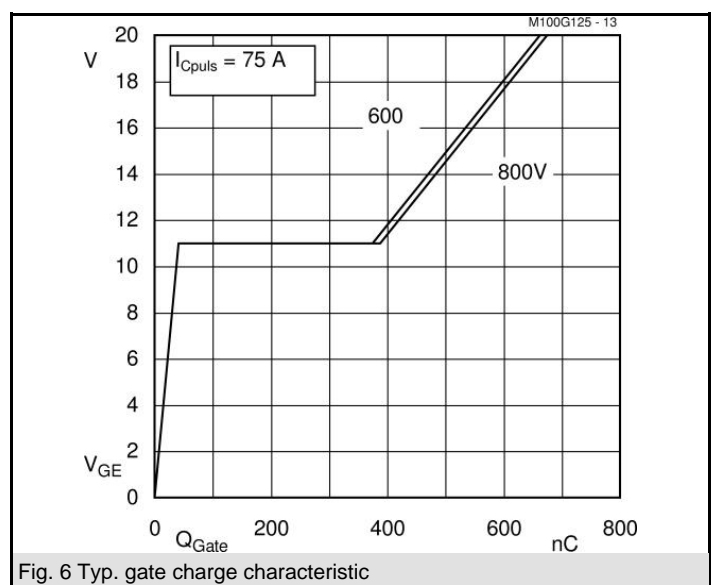
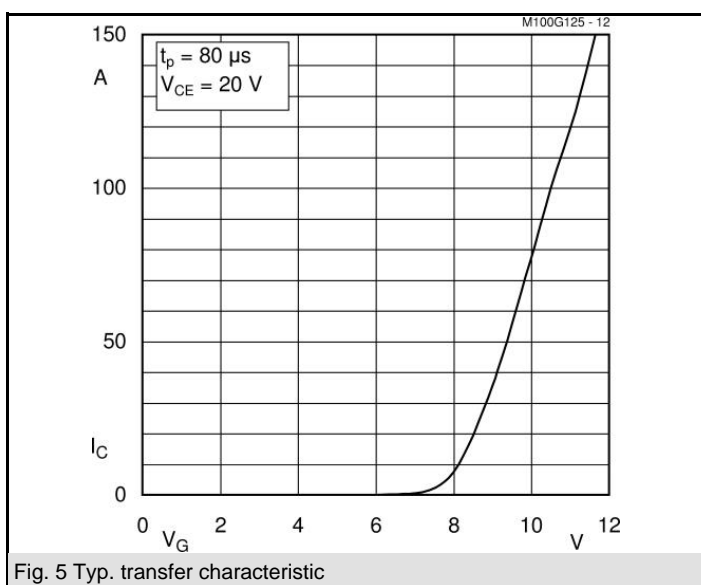
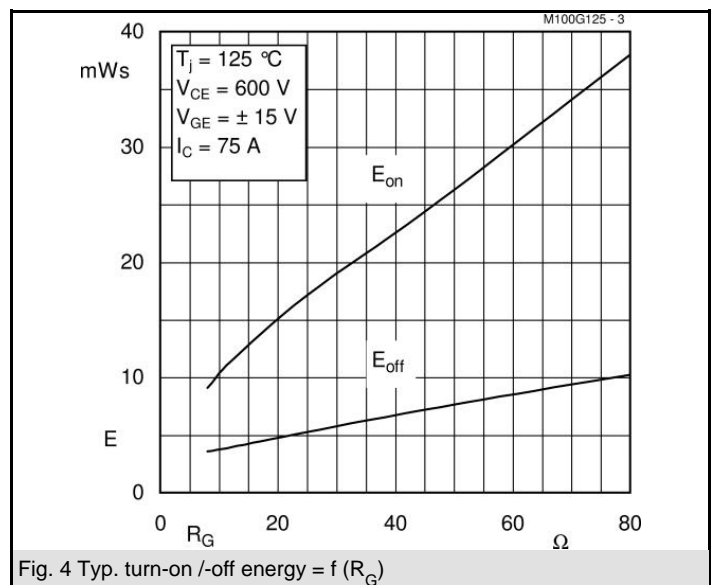
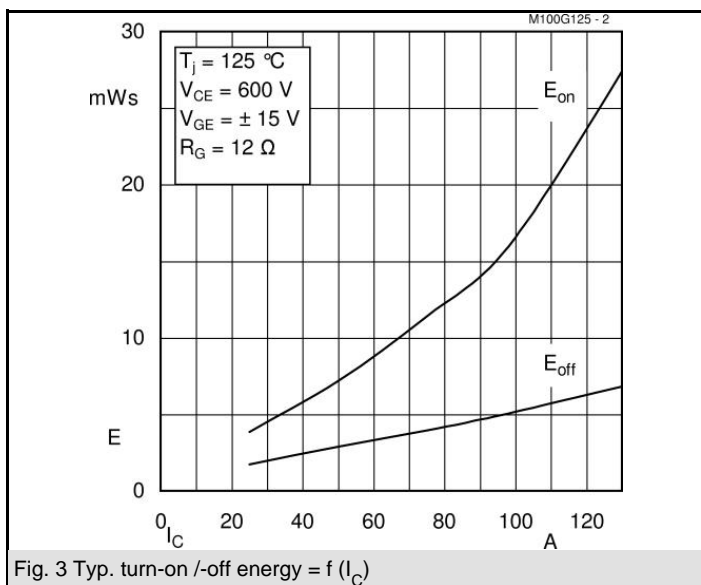
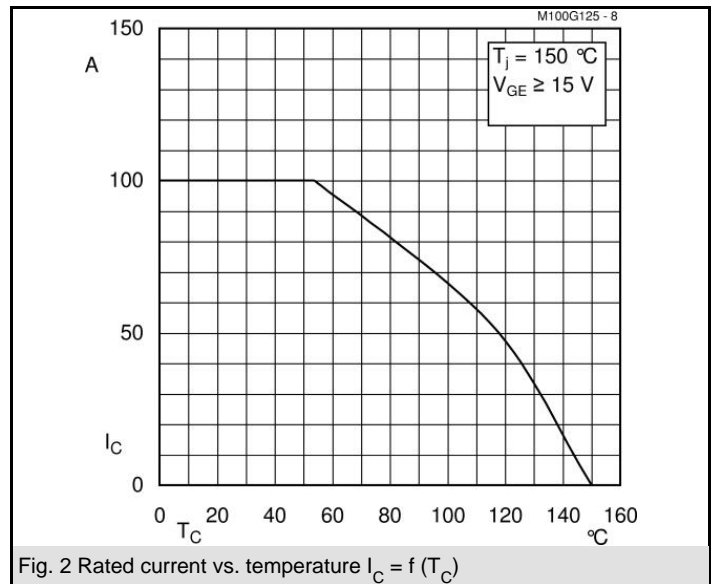
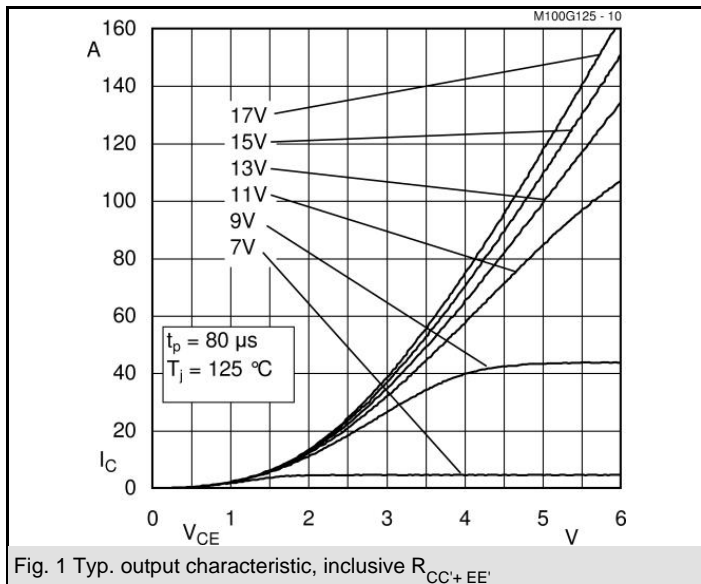
### Typical Applications

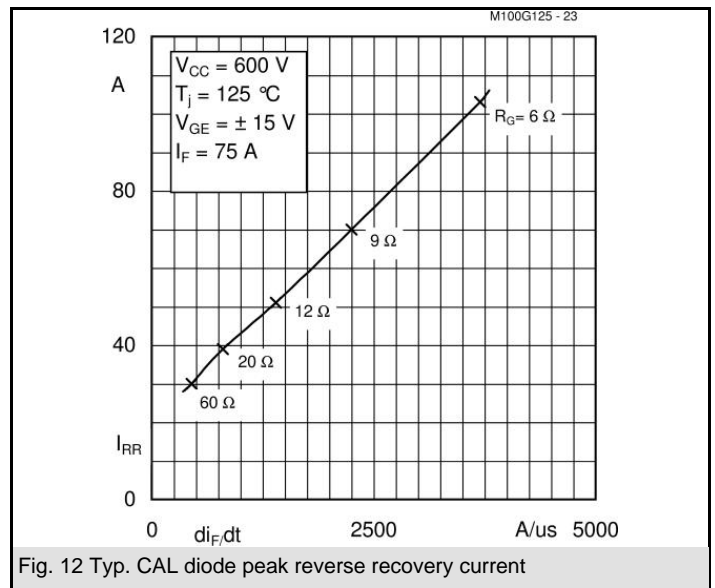
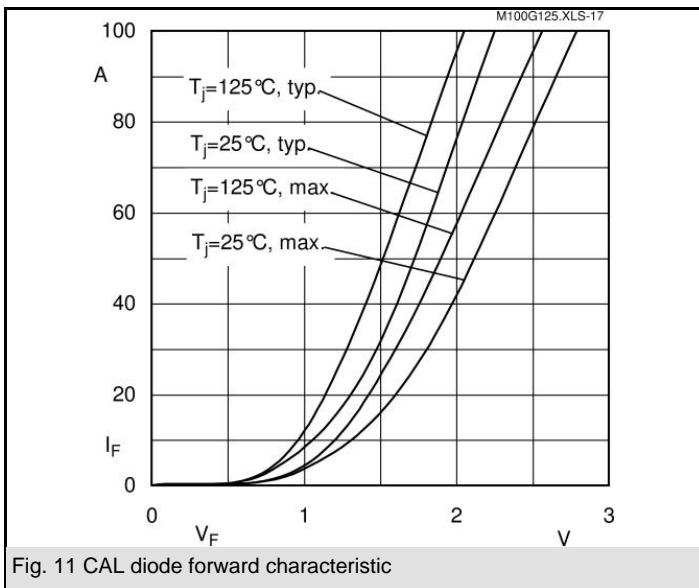
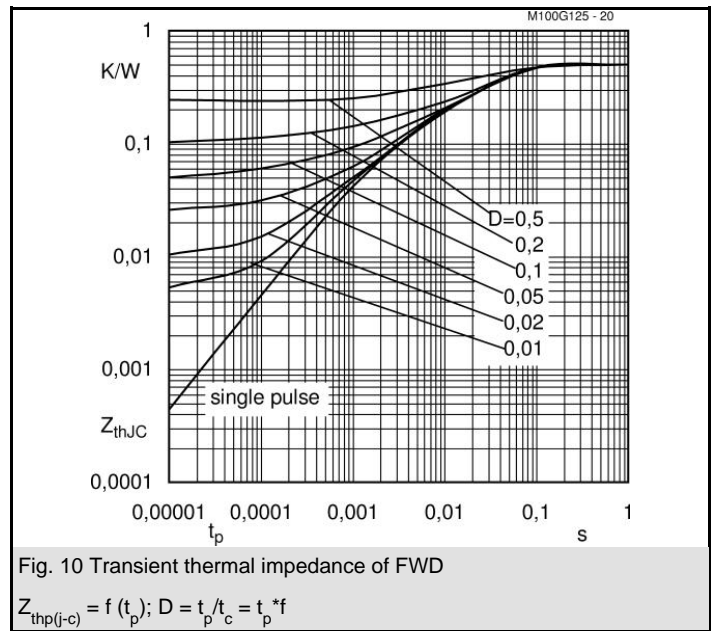
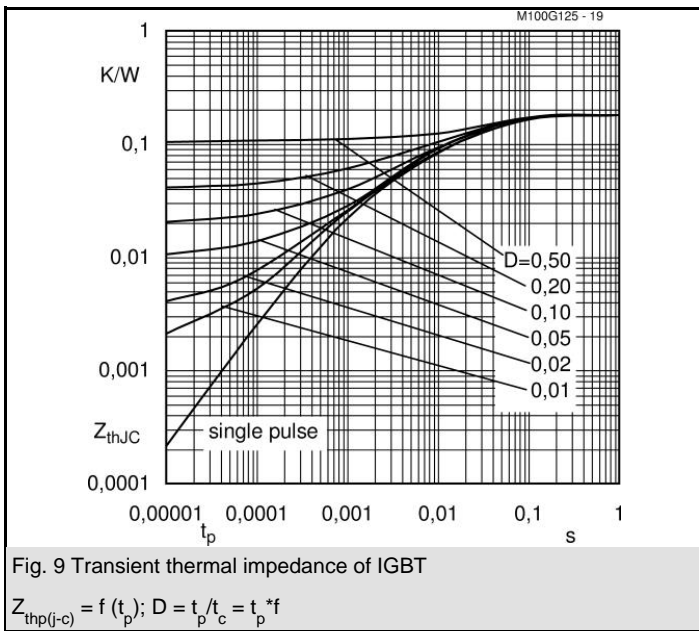
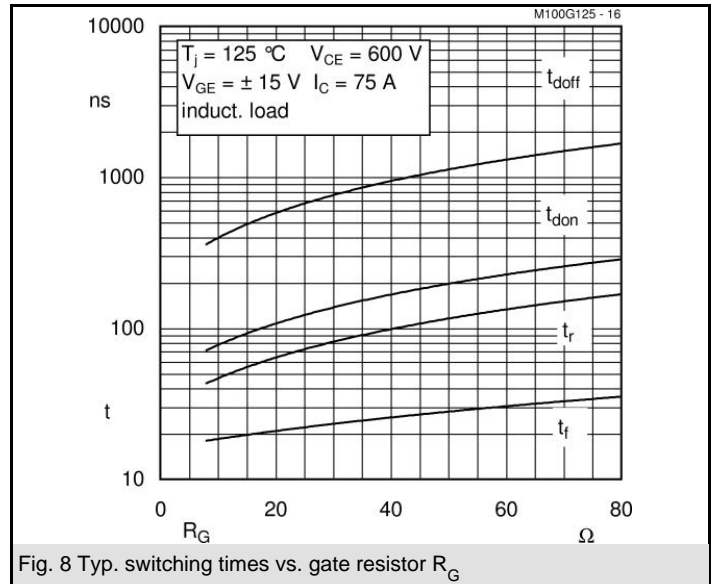
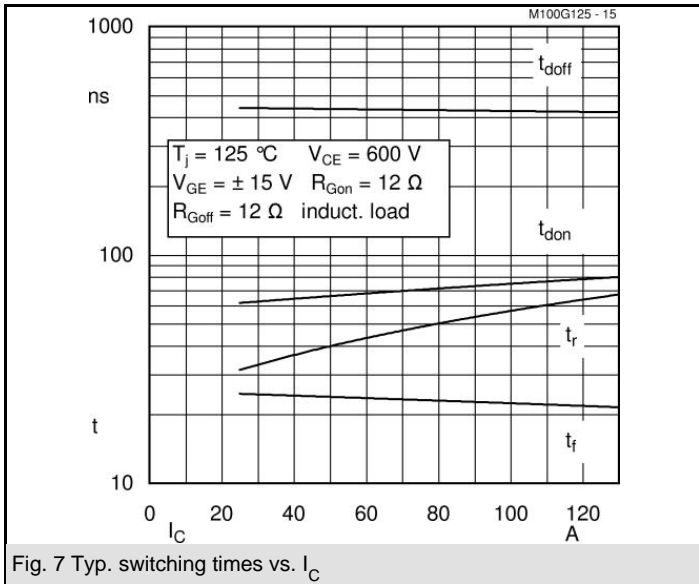
- Switched mode power supplies at  $f_{sw} > 20$  kHz
- Resonant inverters up to 100 kHz
- Inductive heating
- Electronic welders at  $f_{sw} > 20$  kHz



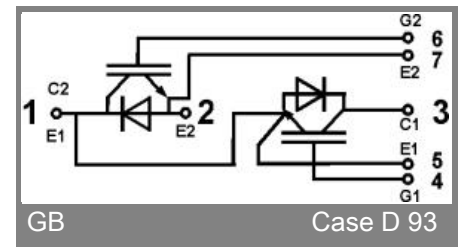
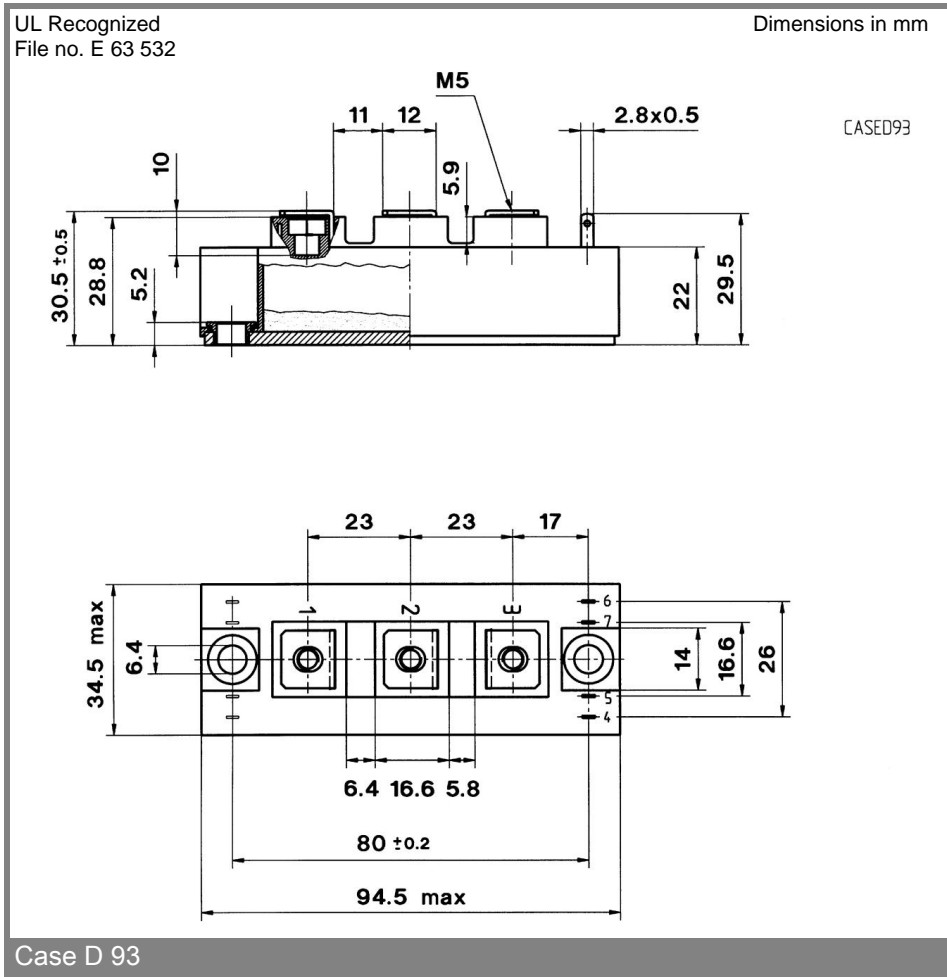
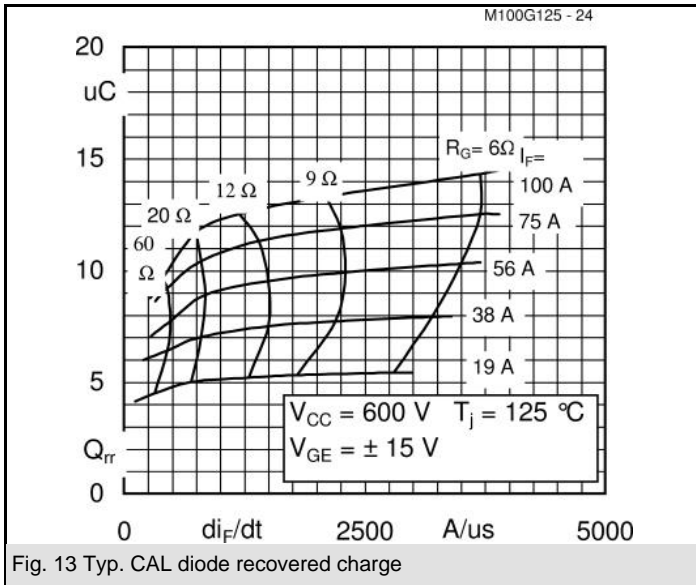
Absolute Maximum Ratings		$T_c = 25\text{ °C}$ , unless otherwise specified	
Symbol	Conditions	Values	Units
<b>IGBT</b>			
$V_{CES}$		1200	V
$I_C$	$T_c = 25$ (85) °C	100 (80)	A
$I_{CRM}$	$T_c = 25$ (85) °C, $t_p = 1$ ms	200 (160)	A
$V_{GES}$		$\pm 20$	V
$T_{vj}$ ( $T_{stg}$ )	$T_{OPERATION} \leq T_{stg}$	- 40 ... + 150 (125)	°C
$V_{isol}$	AC, 1 min.	4000	V
<b>Inverse diode</b>			
$I_F$	$T_c = 25$ (80) °C	95 (65)	A
$I_{FRM}$	$T_c = 25$ (80) °C, $t_p = 1$ ms	200 (160)	A
$I_{FSM}$	$t_p = 10$ ms; sin.; $T_j = 150$ °C	720	A

Characteristics		$T_c = 25\text{ °C}$ , unless otherwise specified			
Symbol	Conditions	min.	typ.	max.	Units
<b>IGBT</b>					
$V_{GE(th)}$	$V_{GE} = V_{CE}$ , $I_C = 2$ mA	4,5	5,5	6,5	V
$I_{CES}$	$V_{GE} = 0$ , $V_{CE} = V_{CES}$ , $T_j = 25$ (125) °C		0,15	0,45	mA
$V_{CE(TO)}$	$T_j = 25$ (125) °C				V
$r_{CE}$	$V_{GE} = 15$ V, $T_j = 25$ (125) °C				mΩ
$V_{CE(sat)}$	$I_C = 75$ A, $V_{GE} = 15$ V, chip level		3,3	3,85	V
$C_{ies}$	under following conditions		5	6,6	nF
$C_{oes}$	$V_{GE} = 0$ , $V_{CE} = 25$ V, $f = 1$ MHz		0,72	0,9	nF
$C_{res}$			0,38	0,5	nF
$L_{CE}$				25	nH
$R_{CC'+EE'}$	res., terminal-chip $T_c = \text{°C}$				mΩ
$t_{d(on)}$	$V_{CC} = 600$ V, $I_C = 75$ A		80		ns
$t_r$	$R_{Gon} = R_{Goff} = 8$ Ω, $T_j = 125$ °C		40		ns
$t_{d(off)}$	$V_{GE} = \pm 15$ V		360		ns
$t_f$			20		ns
$E_{on} (E_{off})$			9 (3,5)		mJ
<b>Inverse diode</b>					
$V_F = V_{EC}$	$I_F = 75$ A; $V_{GE} = 0$ V; $T_j = 25$ (125) °C		2 (1,8)	2,5	V
$V_{(TO)}$	$T_j = 125$ ( ) °C			1,2	V
$r_T$	$T_j = 125$ ( ) °C		12	15	mΩ
$I_{RRM}$	$I_F = 75$ A; $T_j = 25$ ( 125 ) °C		27 (40)		A
$Q_{rr}$	$di/dt = A/\mu s$		3 (10)		μC
$E_{rr}$	$V_{GE} = V$				mJ
<b>Thermal characteristics</b>					
$R_{th(j-c)}$	per IGBT			0,18	K/W
$R_{th(j-c)D}$	per Inverse Diode			0,5	K/W
$R_{th(c-s)}$	per module			0,05	K/W
<b>Mechanical data</b>					
$M_s$	to heatsink M6	3		5	Nm
$M_t$	to terminals M5	2,5		5	Nm
w				160	g





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This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.